National Semiconductor

54F/74F273 Octal D Flip-Flop

General Description

The 'F273 has eight edge-triggered D-type flip-flops with individual D inputs and Q outputs. The common buffered Clock (CP) and Master Reset (\overline{MR}) inputs load and reset (clear) all flip-flops simultaneously.

The register is fully edge-triggered. The state of each D input, one setup time before the LOW-to-HIGH clock transition, is transferred to the corresponding flip-flop's Q output.

All outputs will be forced LOW independently of Clock or Data inputs by a LOW voltage level on the $\overline{\text{MR}}$ input. The device is useful for applications where the true output only is required and the Clock and Master Reset are common to all storage elements.

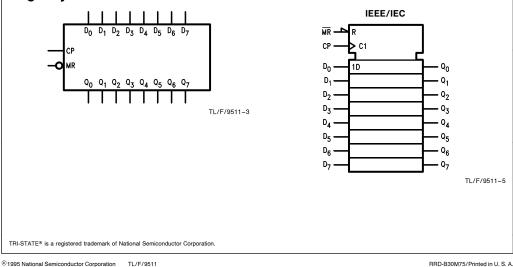
Features

- Ideal buffer for MOS microprocessor or memory
- Eight edge-triggered D flip-flops
- Buffered common clock
 Buffered asynchronous
- Buffered, asynchronous Master ResetSee 'F377 for clock enable version
- See 'F377 for clock enable version
 See 'F373 for transparent latch version
- See 'F373 for transparent laten version
 See 'F374 for TRI-STATE® version
- Guaranteed 4000V minimum ESD protection
- Package Commercial Military Package Description Number 74F273PC N20A 20-Lead (0.300" Wide) Molded Dual-In-Line 54F273DM (Note 2) J20A 20-Lead Ceramic Dual-In-Line 74F273SC (Note 1) M20B 20-Lead (0.300" Wide) Molded Small Outline, JEDEC 74F273SJ (Note 1) M20D 20-Lead (0.300" Wide) Molded Small Outline, EIAJ 54F273FM (Note 2) W20A 20-Lead Cerpack 54F273LM (Note 2) E20A 20-Lead Ceramic Leadless Chip Carrier, Type C

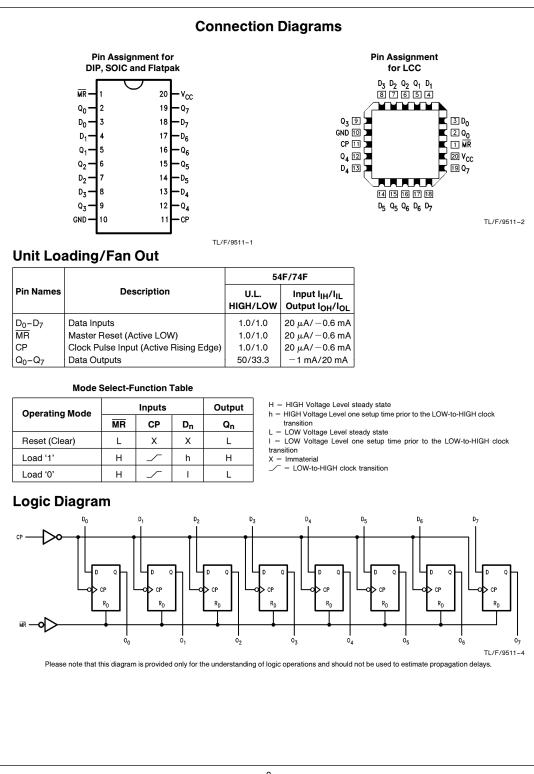
Note 1: Devices also available in 13" reel. Use suffix = SCX and SJX.

Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB, FMQB and LMQB.

Logic Symbols



May 1995



Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

-65°C to +150°C
-55°C to +125°C
−55°C to +175°C −55°C to +150°C
-0.5V to +7.0V
-0.5V to $+7.0V$
-30 mA to $+5.0$ mA
-0.5V to V _{CC}
-0.5V to +5.5V
twice the rated I _{OL} (mA)
4000V
es beyond which the device may

be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

Recommended Operating Conditions

Free Air Ambient Temperature Military Commercial Supply Voltage Military Commercial

+ 4.5V to + 5.5V + 4.5V to + 5.5V

-55°C to +125°C 0°C to +70°C

Symbol	Parameter		54F/74F			Units	Vcc	Conditions	
Symbol	Faramete	•	Min	Тур	Max	Units	•00	Conditions	
VIH	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V _{IL}	Input LOW Voltage				0.8	V		Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Vo	ltage			-1.2	V	Min	$I_{IN} = -18 \text{ mA}$	
V _{OH}	Output HIGH Voltage	Mil 10% V _{CC} 5% V _{CC}	2.5 2.5 2.7			V	Min	$I_{OH} = -1 \text{ mA}$	
V _{OL}	Output LOW Voltage	Mil 10% V _{CC} 5% V _{CC}			0.5 0.5 0.5	V	Min	I _{OL} = 20 mA	
Ι _Η	Input HIGH Current	54F 74F			20.0 5.0	μΑ	Мах	$V_{IN} = 2.7V$	
I _{BVI}	Input HIGH Current Breakdown Test	54F 74F			100 7.0	μΑ	Max	$V_{IN} = 7.0V$	
ICEX	Output HIGH Leakage Current	54F 74F			250 50	μΑ	Мах	$V_{OUT} = V_{CC}$	
V _{ID}	Input Leakage Test	74F	4.75			v	0.0	$I_{ID} = 1.9 \ \mu A$ All other pins grounded	
I _{OD}	Output Leakage Circuit Current	74F			3.75	μΑ	0.0	V _{IOD} = 150 mV All other pins grounded	
IIL	Input LOW Current				-0.6	mA	Max	$V_{IN} = 0.5V$	
I _{OS}	Output Short-Circuit C	Current	-60		-150	mA	Max	$V_{OUT} = 0V$	
I _{CCH} I _{CCL}	Power Supply Current	t			44 56	mA	Max	$CP = \checkmark$ $D_n = \overline{MR} = HIGH$	

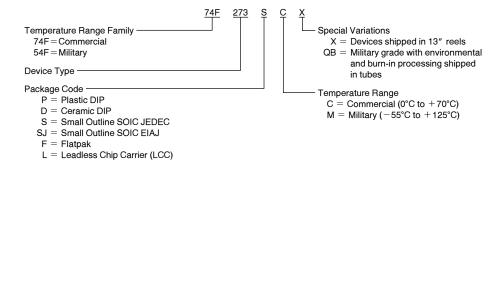
AC Electrical Characteristics										
		$74F \\ T_{A} = +25^{\circ}C \\ V_{CC} = +5.0V \\ C_{L} = 50 \text{ pF}$			54F T _A , V _{CC} = Mil C _L = 50 pF		$74F$ $T_{A}, V_{CC} = Com$ $C_{L} = 50 \text{ pF}$		Units	
Symbol	Parameter									
		Min	Тур	Max	Min	Max	Min	Max		
f _{max}	Maximum Clock Frequency	160			95		130		MHz	
t _{PLH} t _{PHL}	Propagation Delay Clock to Output	3.0 4.0		7.0 9.00	2.5 3.0	9.5 11.0	2.5 3.5	7.5 9.0	ns	
t _{PLH} t _{PHL}	Propagation Delay MR to Output	4.5		9.5	3.0	11.0	4.0	10.0	ns	

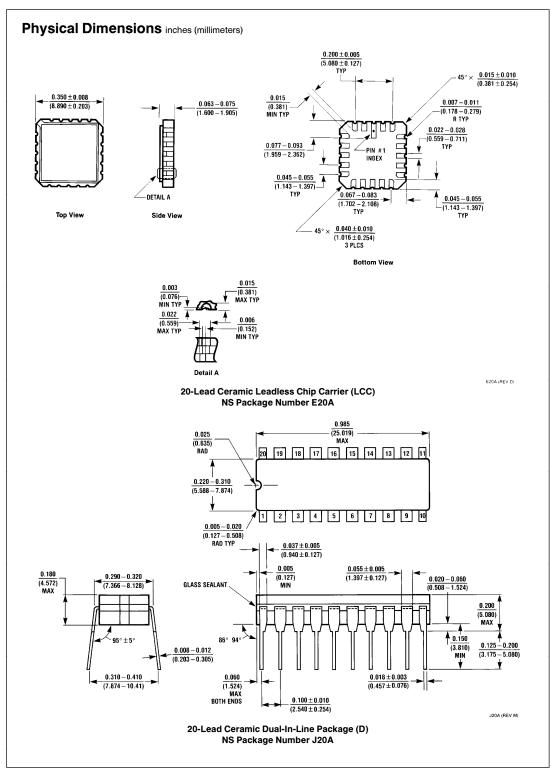
AC Operating Requirements

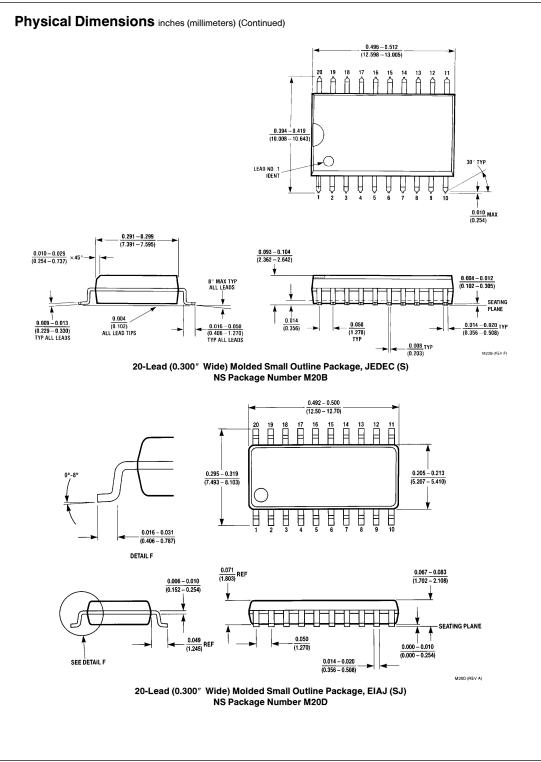
	Parameter	74F		54	ŀF	74F		
Symbol			+ 25°C + 5.0V	T _A , V _{CC}	_c = Mil	T _A , V _{CC} = Com		Units
		Min	Мах	Min	Max	Min	Max	1
t _s (H) t _s (L)	Setup Time, HIGH or LOW Data to CP	3.0 3.5		3.5 4.0		3.0 3.5		– ns
t _h (H) t _h (L)	Hold Time, HIGH or LOW Data to CP	0.5 1.0		1.0 1.0		0.5 1.0		
t _w (L)	MR Pulse Width, LOW	6.0		4.0		6.0		ns
t _w (H) t _w (L)	CP Pulse Width HIGH or LOW	6.0 6.0		5.0 5.0		6.0 6.0		ns
t _{rec}	Recovery Time, MR to CP	3.0		4.5		3.5		ns

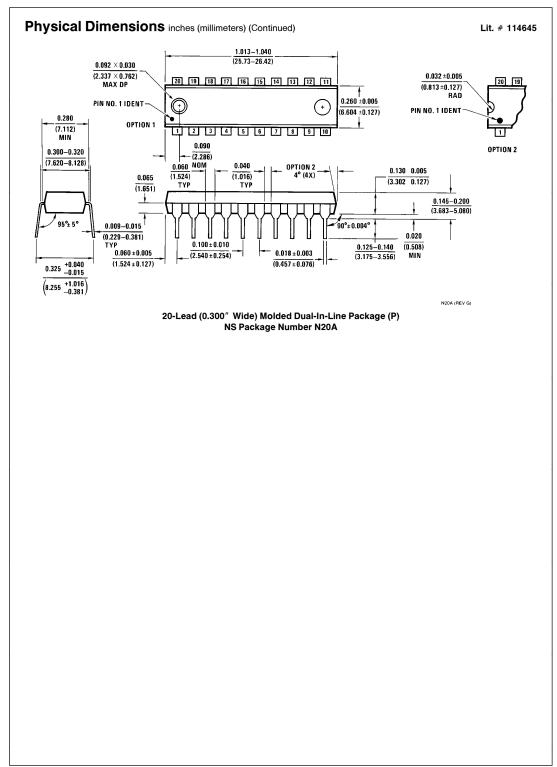
Ordering Information

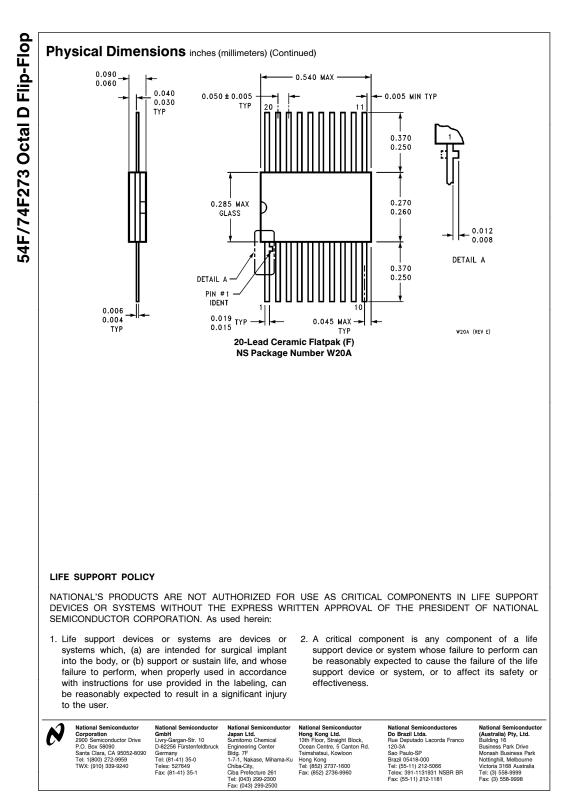
The device number is used to form part of a simplified purchasing code where a package type and temperature range are defined as follows:











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